



Measurement of Υ in p+p collisions in the STAR experiment



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EUROPEAN UNION
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SOCIAL FUND



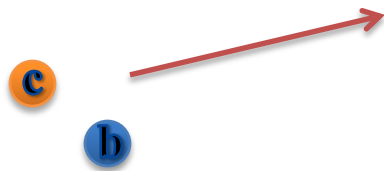
Outline

- Why Upsilon at RHIC?
- Experimental approach in STAR
- Measured yields and expected precision
 - Efficiency studies
- Prospects for Upsilon measurements in STAR

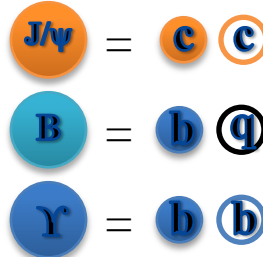
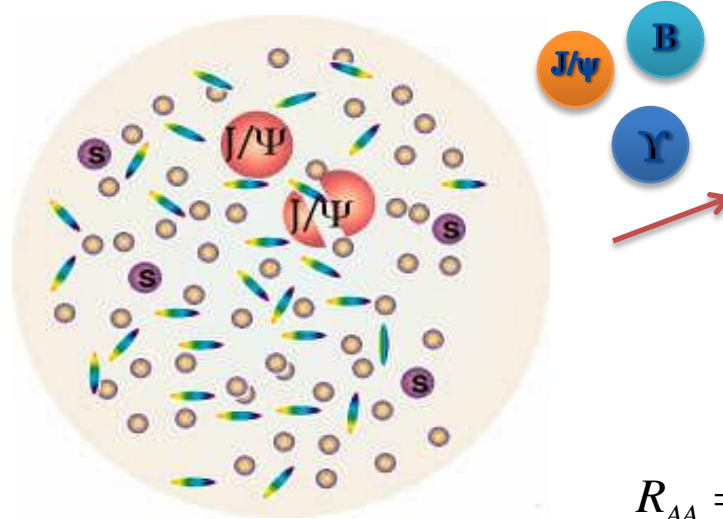


Physics introduction

Heavy quarks (b,c) are produced in an early stage of the collision (before quark-gluon plasma (QGP) formation)



Heavy quarks are „probes”, which interact with QGP



Hadrons containing heavy quarks can be observed and their modification in QGP measured.

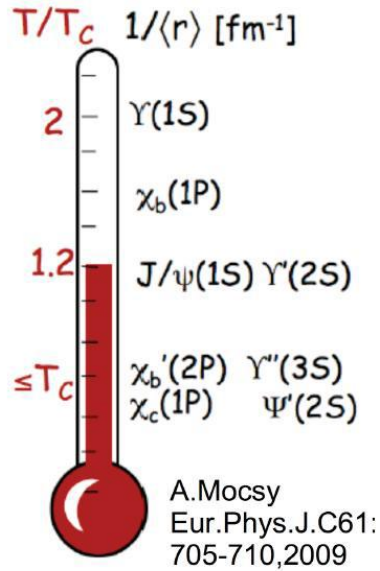
$$R_{AA} = \frac{1}{N_{coll}} \frac{(\text{invariant yield})_{AA}}{(\text{invariant yield})_{pp}}$$

From this we can learn about QGP and interactions between quarks and gluons.

•Suppression of J/ψ in A+A is a signature of QGP formation.

T.Matsui and H.Satz 1986 Phys. Lett. B 178:416, 1986

Quarkonium suppression

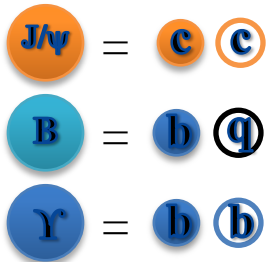


- Upsilon states provide a cleaner probe than J/ψ , because of smaller regeneration and cold nuclear matter effects
- Sequential suppression of more tightly bound states with increasing temperature – indirect QGP temperature measurement

Á. Mócsy, P. Petreczky, Phys. Rev. D77, 014501 (2008)



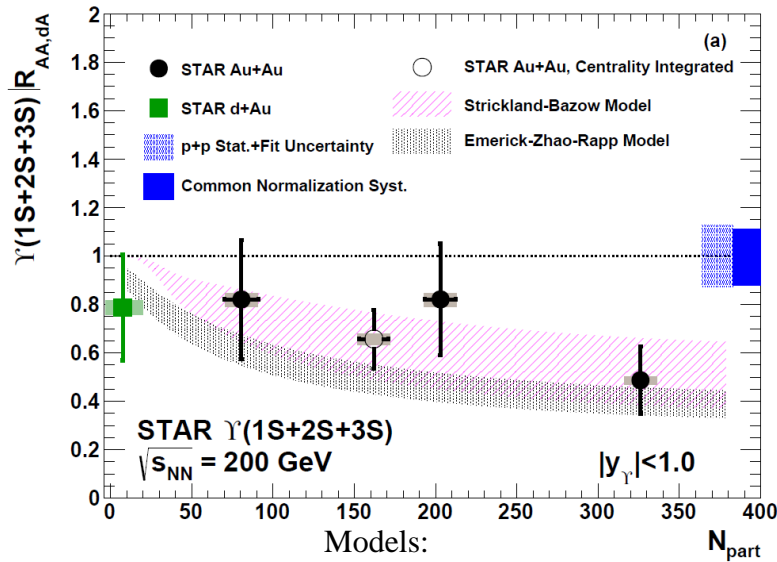
Requires measurements of suppression of different quarkonium states



Why Upsilon at RHIC?

STAR measured R_{AA} for Upsilon 1S+2S+3S and 1S as a function of N_{part} .

- Shows significant suppression for integrated p_T .

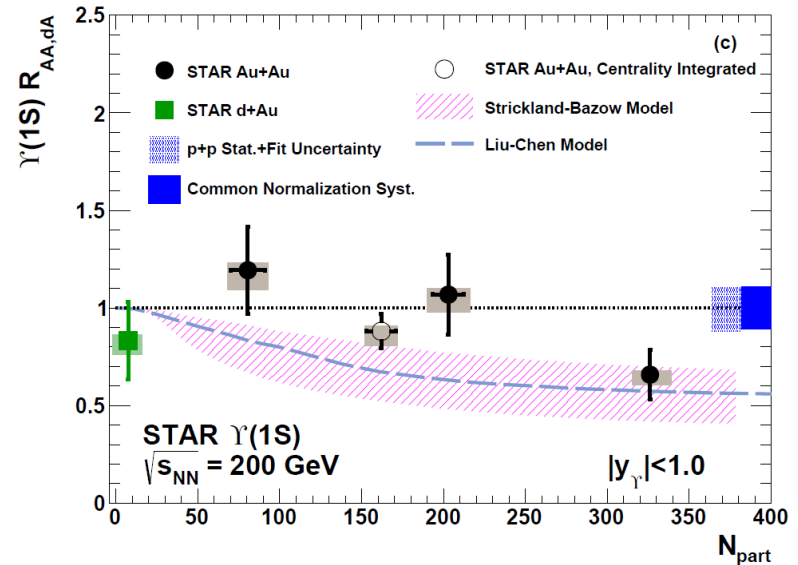


Models:

Hot and cold nuclear matter effects: Strickland, Bazov, Nucl. Phys. A879, 25 (2012)

Hot nuclear matter effects only: arXiv:1009.2585

Phys.Lett. B735 (2014) 127



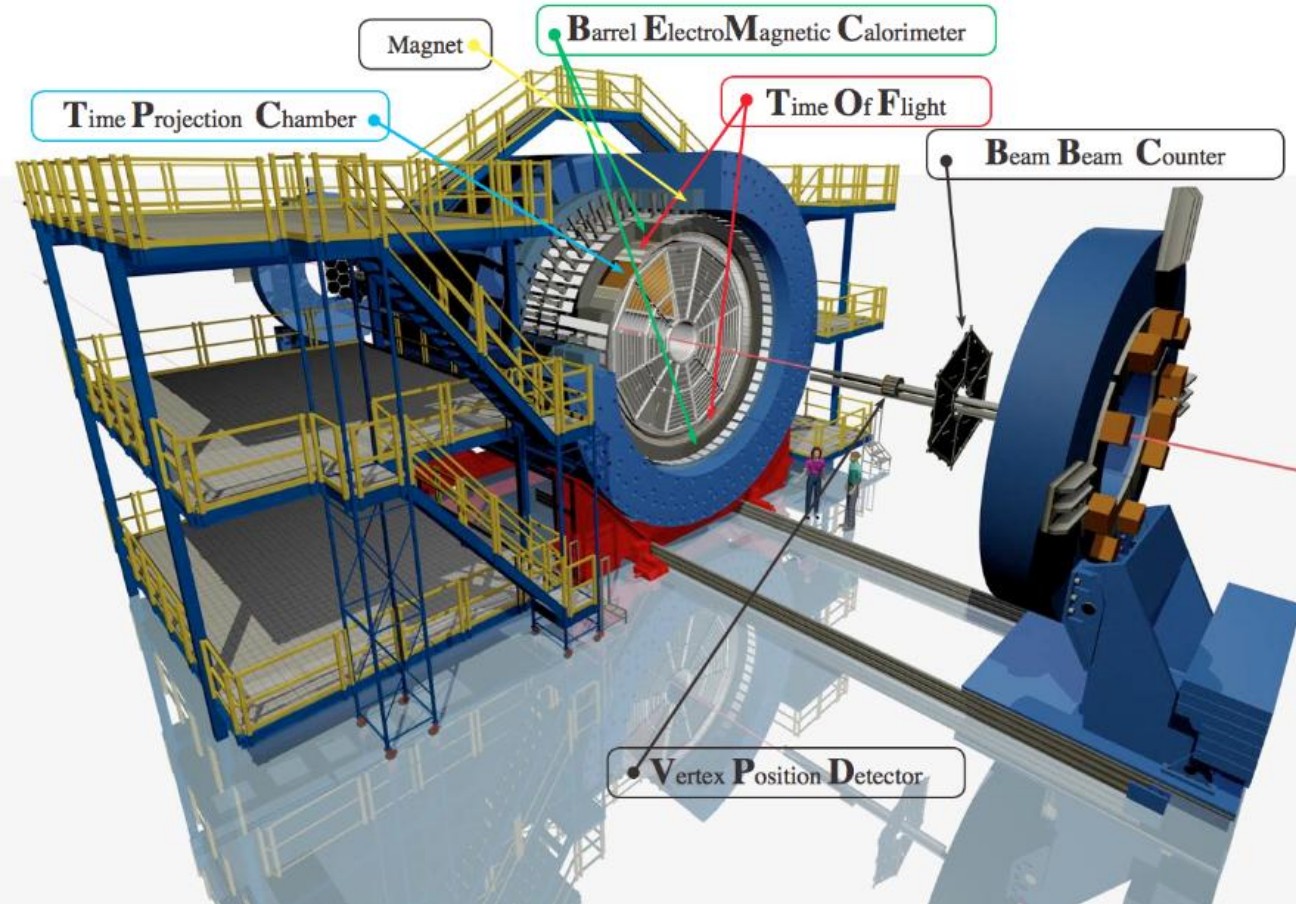
- We need p_T spectrum from p+p as a baseline for $R_{AA}(p_T)$ to study dynamical aspects of Upsilon interaction with QGP.

- STAR p+p 500 GeV provides much better statistical precision (larger $b\bar{b}$ cross section than at 200 GeV)

- Will provide an opportunity to measure ratios of different states in production yields.

STAR experiment

Solenoidal Tracker At RHIC : $-1 < \eta < 1, 0 < \phi < 2\pi$



- TPC: Particle identification via dE/dx and tracking

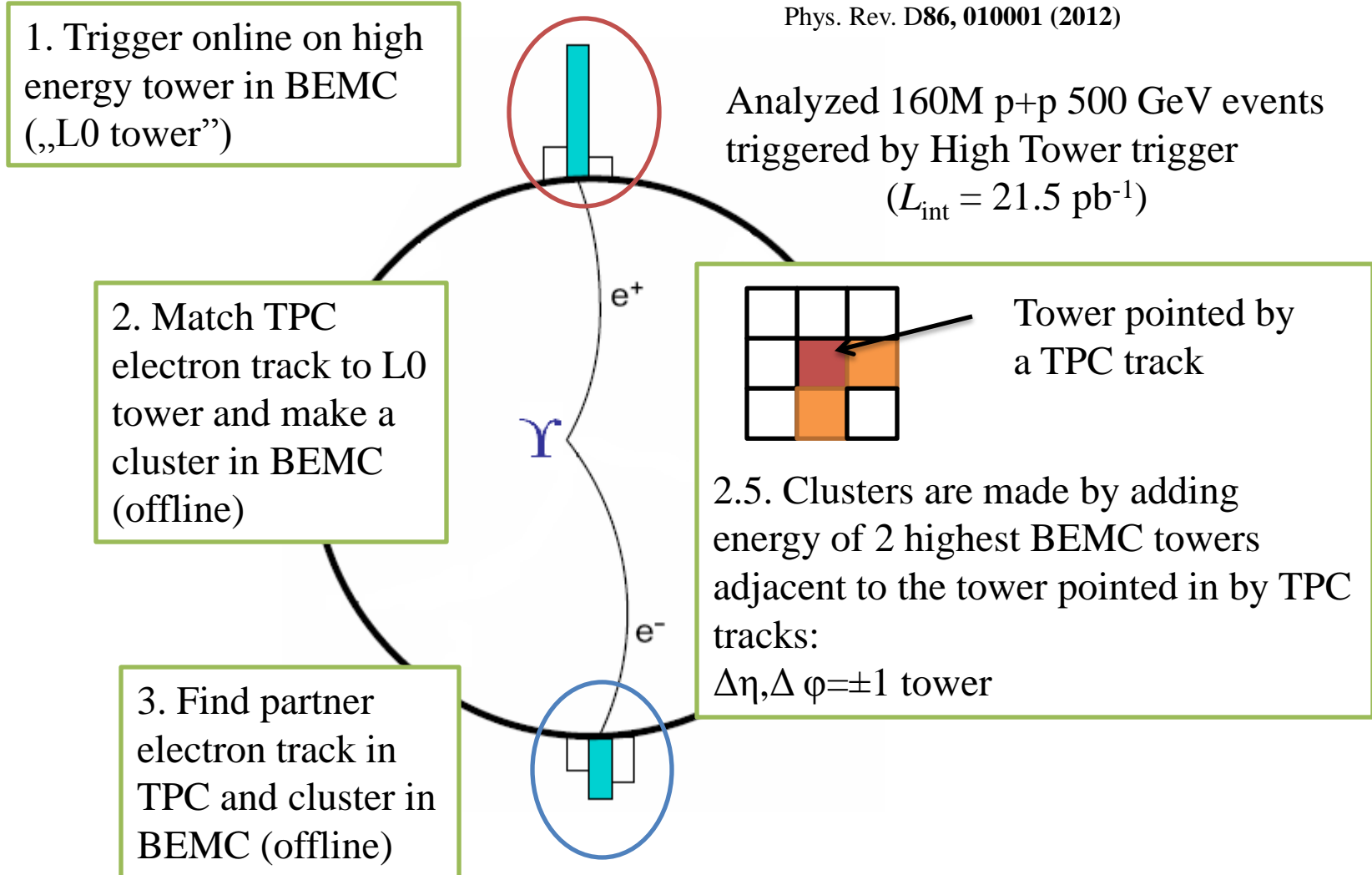
- BEMC: Particle identification via E/p and online High Tower trigger

Experimental approach in STAR

$$Y \rightarrow e^+e^- \text{ BR} = 2.38 \pm 0.11\%$$

Phys. Rev. D86, 010001 (2012)

Analyzed 160M p+p 500 GeV events
triggered by High Tower trigger
($L_{\text{int}} = 21.5 \text{ pb}^{-1}$)



Offline analysis and particle identification

Track which fired the trigger:

Match to L0 tower required

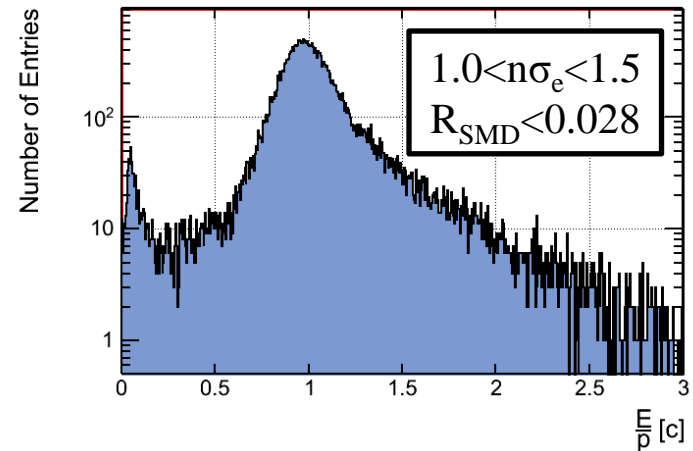
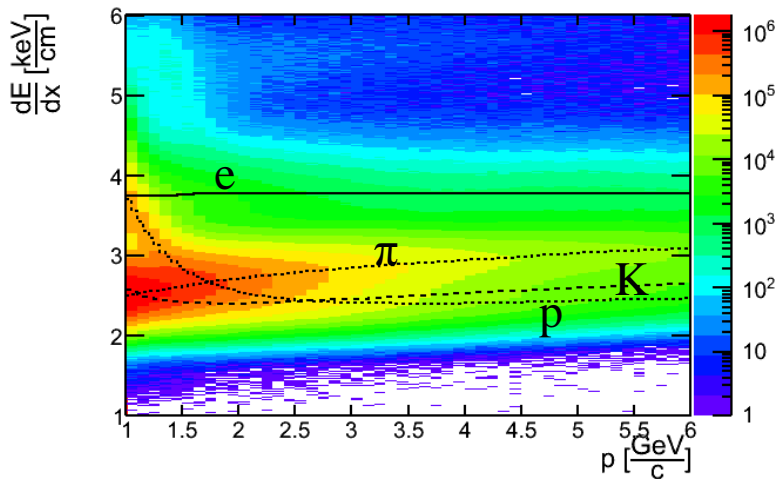
Partner track:

$p > 1 \text{ GeV}/c$

Both tracks:

$-1.2 < n\sigma_e < 3.0$
 $E_{\text{tower}}/E_{\text{cluster}} > 0.5$
 $0.55 < E_{\text{cluster}}/pc < 1.45$
 $R_{\text{SMD}} < 0.028$

dEdx vs p all



Normalized dE/dx: $n\sigma_e = \log\left(\frac{dE/dx_e}{dE/dx|_{\text{Bichsel}}}\right) / \sigma$

Distance between a track projection on BEMC SMD and center of a cluster: $R_{\text{SMD}} = \sqrt{\Delta\eta^2 + \Delta\phi^2}$

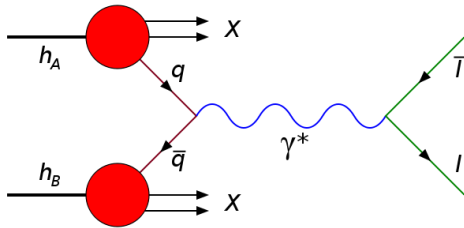
Upsilon signal and backgrounds

Invariant mass histogram of e^+e^- contains:

- Upsilon signal
- Combinatorial background
- described by like sign sum:

$$N_{e^+e^+} + N_{e^-e^-}$$

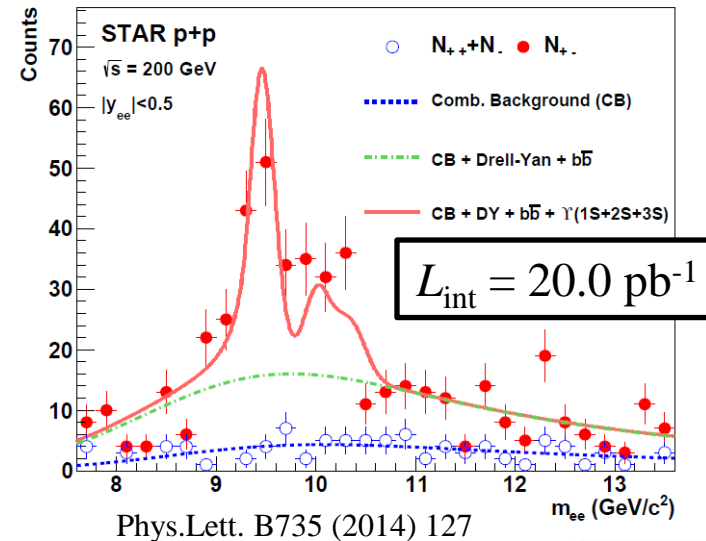
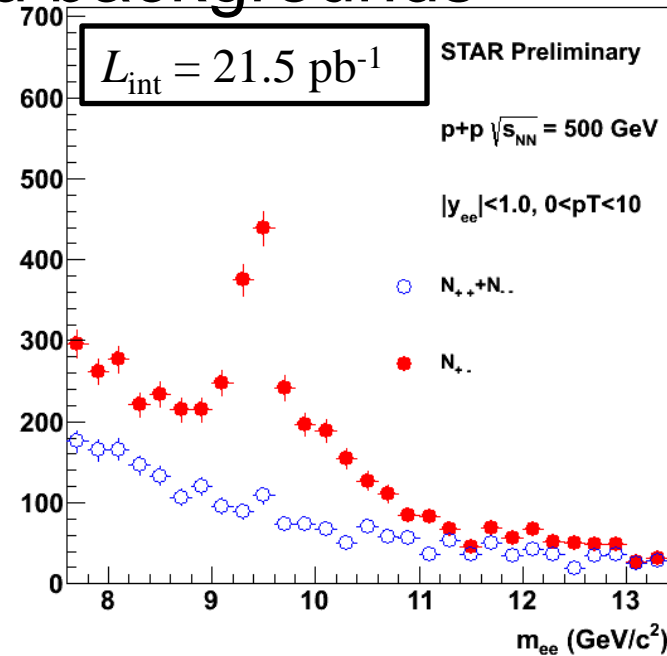
- Drell-Yan background: $q\bar{q} \rightarrow l\bar{l}$



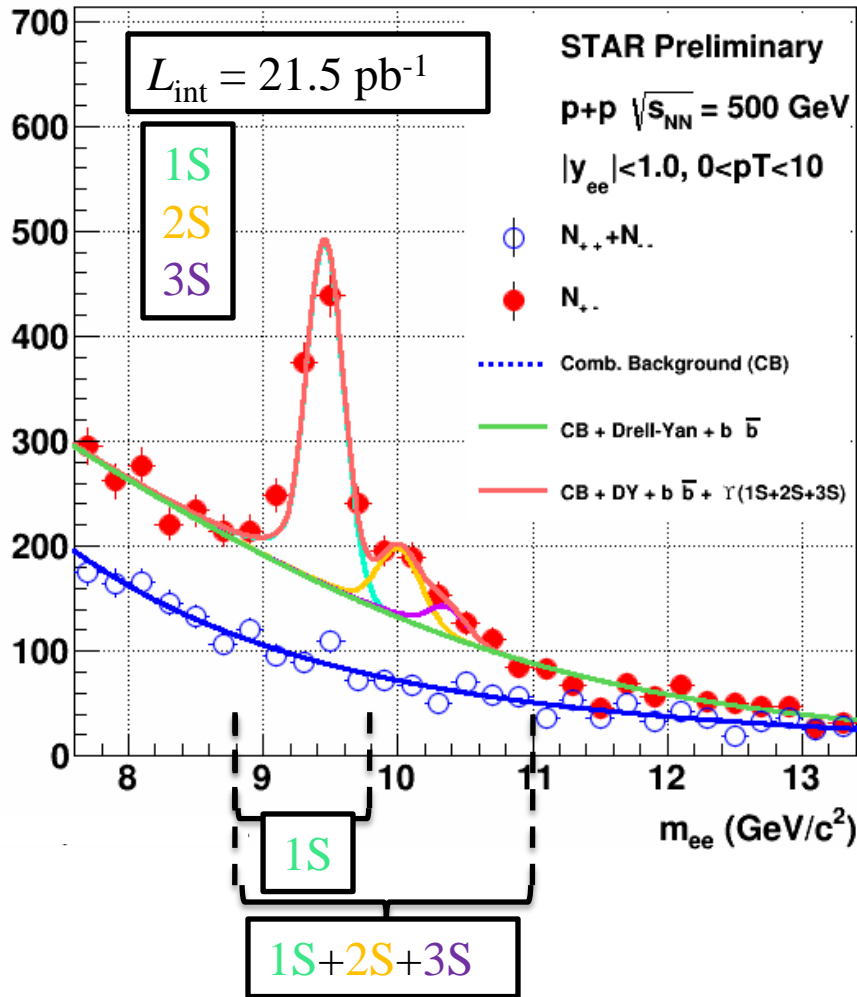
- $b\bar{b}$ background: $b\bar{b} \rightarrow e^+e^-$

Signal extraction strategy:

- describe background by a function and do a simultaneous fit to signal and combinatorial background
- integrate counts in an Upsilon mass range and subtract background



Upsilon signal



Signal calculated by integrating counts and subtracting backgrounds from fits:

$$N_Y = N_{e+e-} - N_{CB}^{Fit} - N_{DY}^{Fit} - N_{b\bar{b}}^{Fit}$$

Background fit functions

$$f_{b\bar{b}} = N \frac{m^A}{\left(1 + \frac{m}{B}\right)^C} \quad f_{DY} = N \frac{1}{\left(1 + \frac{m}{A}\right)^B}$$

$$f_{CB} = N \cdot A \cdot \exp\left(\frac{-m}{B}\right) + N \cdot (1-A) \cdot \exp\left(\frac{-m}{C}\right)$$

1S yield extracted in 8.8-9.8 GeV/c^2 range.

1S+2S+3S extracted in 8.8-11 GeV/c^2 range.

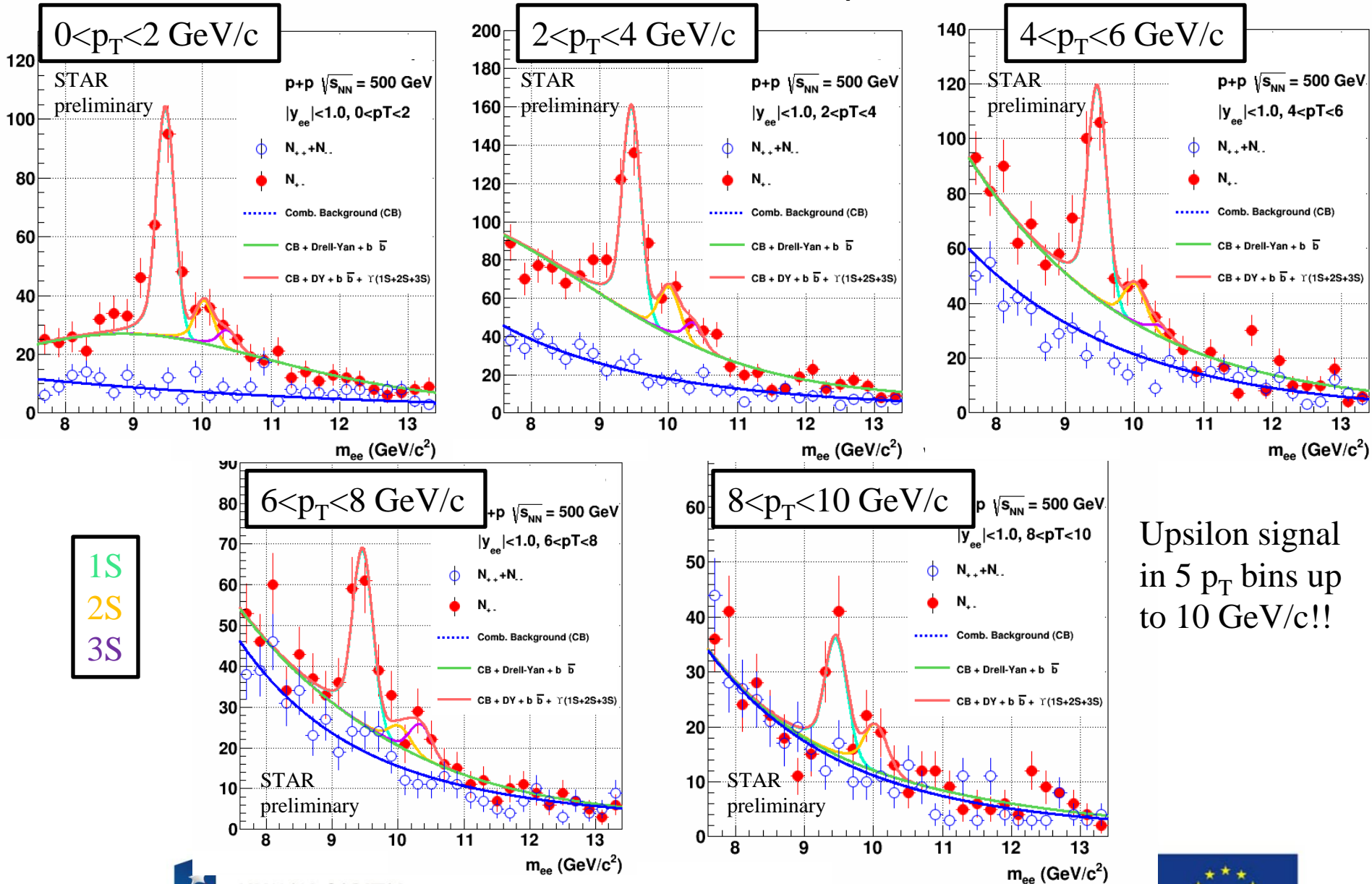
1S+2S+3S yield: 831 ± 45

1S yield: 653 ± 35

Statistical uncertainty $\sim 5\%$

($\sim 20\%$ stat.+fit uncertainty for published p+p 200 GeV results)

Upsilon signal – p_T bins

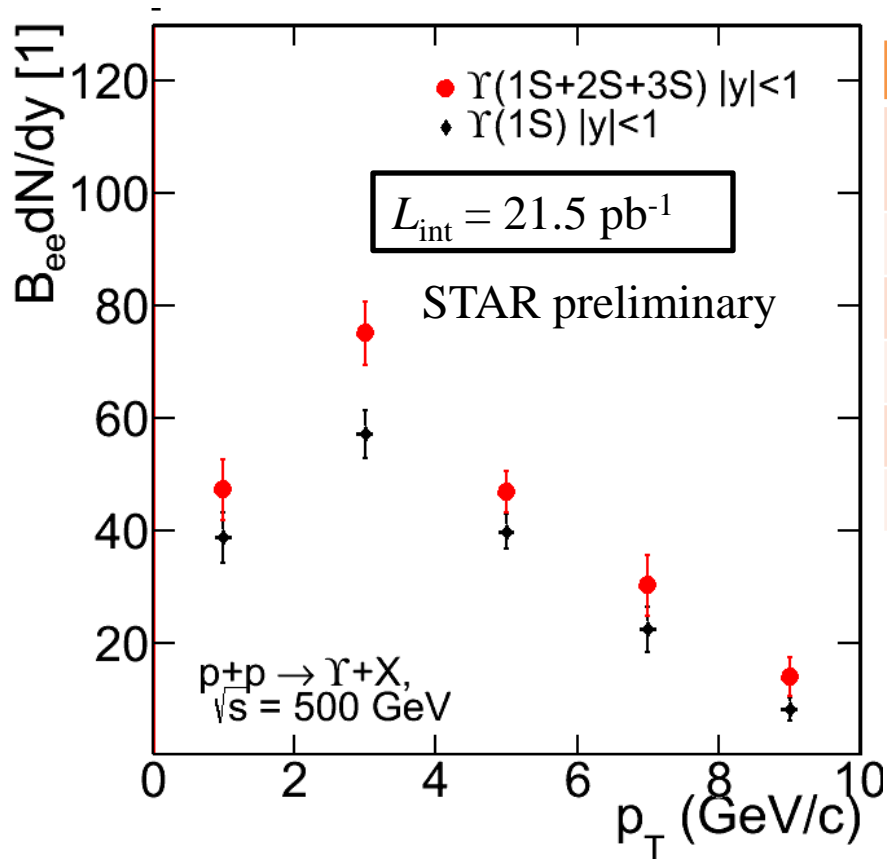


1S
2S
3S

Upsilon signal
in 5 p_T bins up
to 10 GeV/c!!



Uncorrected p_T spectrum

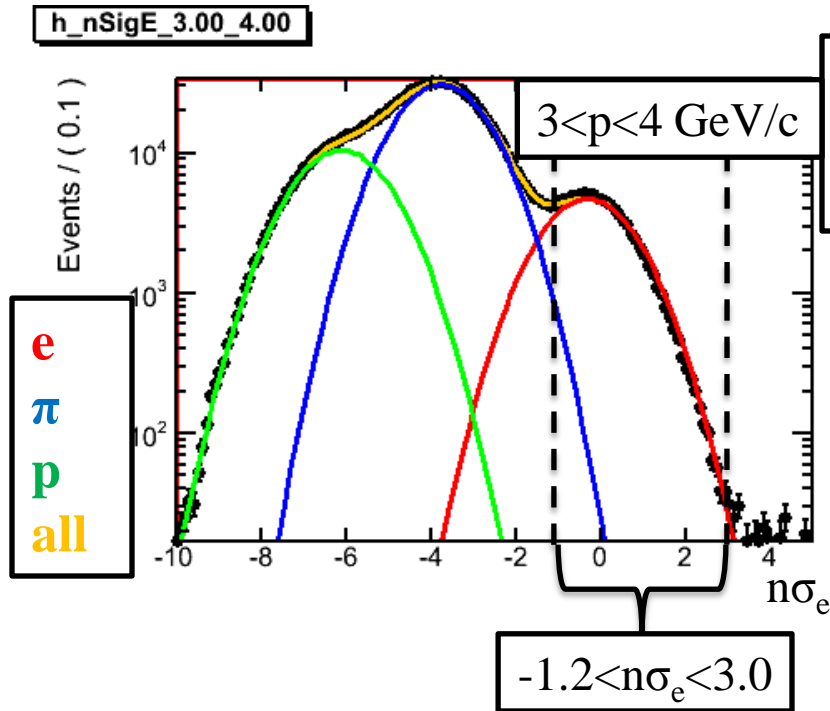


	1S+2S+3S		
p_T [GeV/c]	Yield	Uncertainty	Uncertainty %
0-2	189	22	12
2-4	301	23	8
4-6	188	15	8
6-8	121	22	19
8-10	56	15	27

	1S		
p_T [GeV]	Yield	Uncertainty	Uncertainty %
0-2	155	18	12
2-4	229	18	8
4-6	159	13	9
6-8	90	16	18
8-10	32.9	8.4	26

- Statistical uncertainty < 20% for $p_T < 8 \text{ GeV}/c$
- Even better < 10% for $2 < p_T < 6 \text{ GeV}/c$

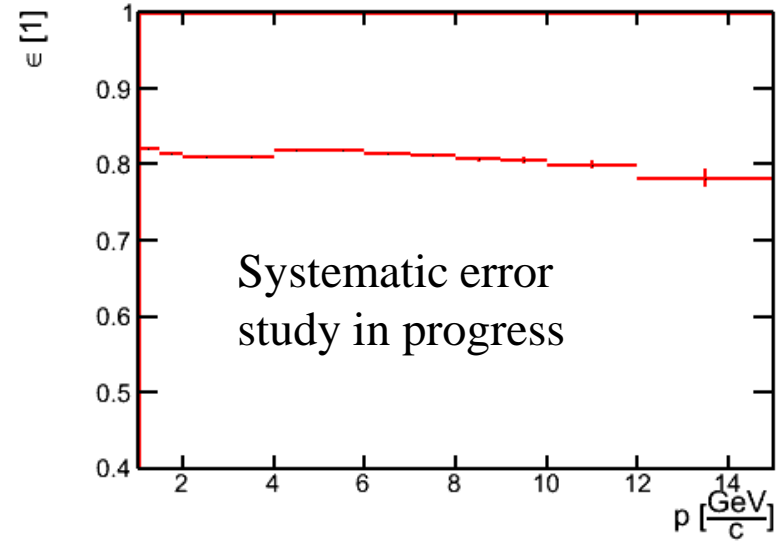
dE/dx cut efficiency



$E_{\text{tower}}/E_{\text{cluster}} > 0.75$
 $0.7 < E_{\text{cluster}}/pc < 1.3$
 $R_{\text{SMD}} < 0.02$

Obtained a cleaner sample for dE/dx cut efficiency calculation and fitted multiple gaussians to $n\sigma_e$ distributions in momentum slices

dE/dx cut efficiency



Efficiency is a ratio of the integral of the electron gaussian within cut range to the total electron gaussian

$$\text{Normalized } dE/dx: n\sigma_e = \log\left(\frac{dE/dx_e}{dE/dx|_{\text{Bichsel}}}\right) / \sigma$$

BEMC E/p efficiency

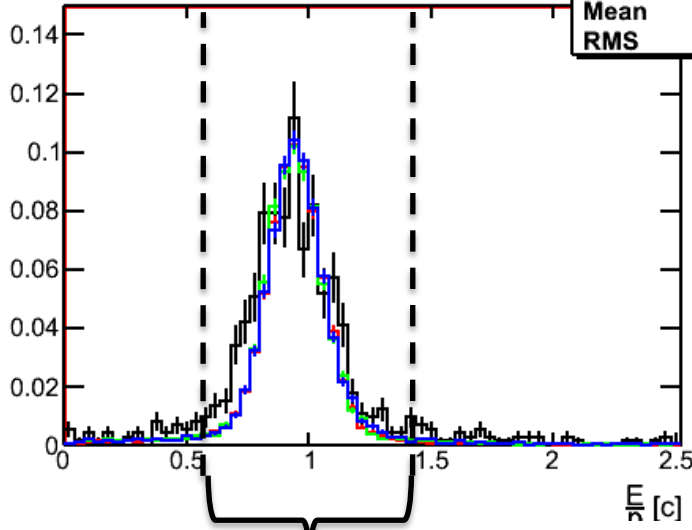
h_data_p_Eclu

$2 < p < 3 \text{ GeV}$

h_data_p_Eclu_2_3	
Entries	734
Mean	0.9502
RMS	0.2976

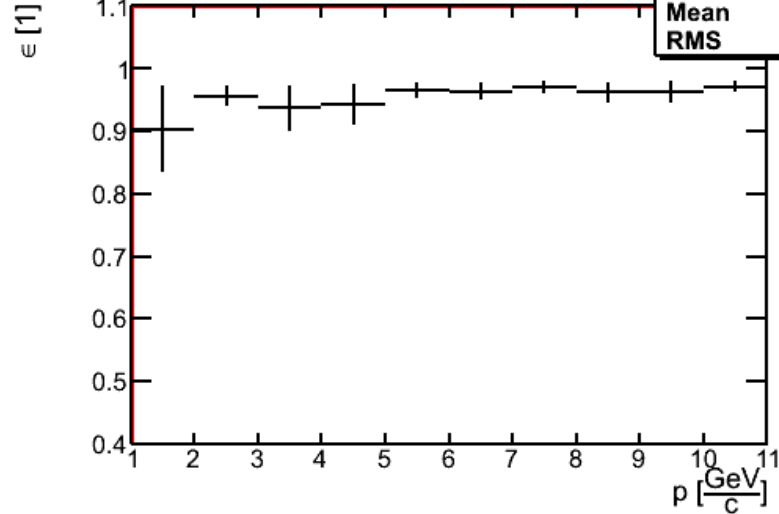
h_data_p_EoP_eff

h_data_p_EoP_eff_Av	
Entries	40
Mean	6.046
RMS	2.862



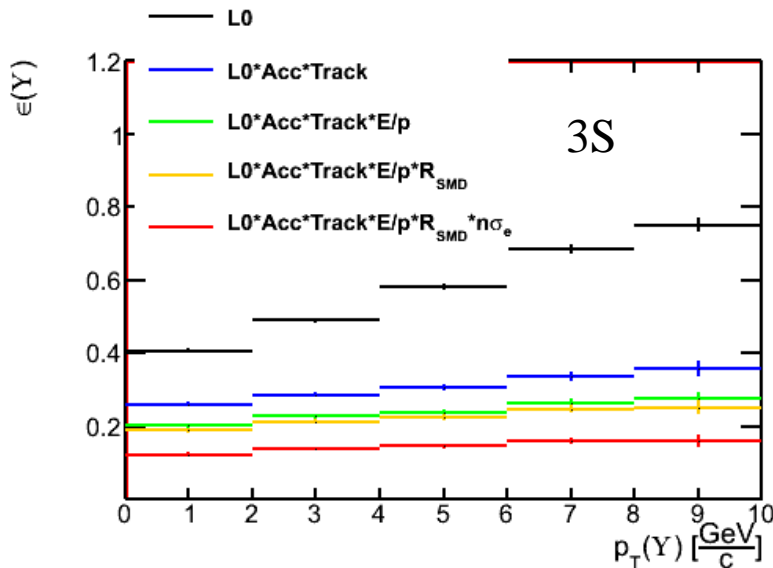
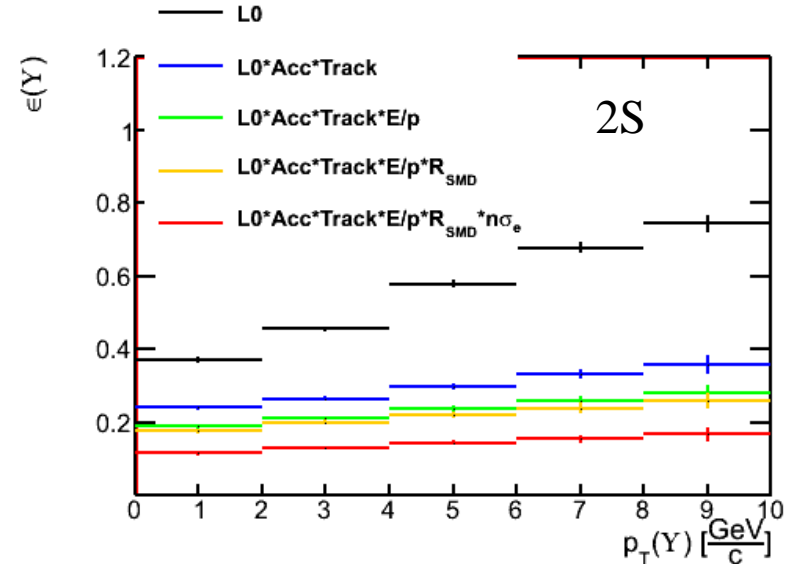
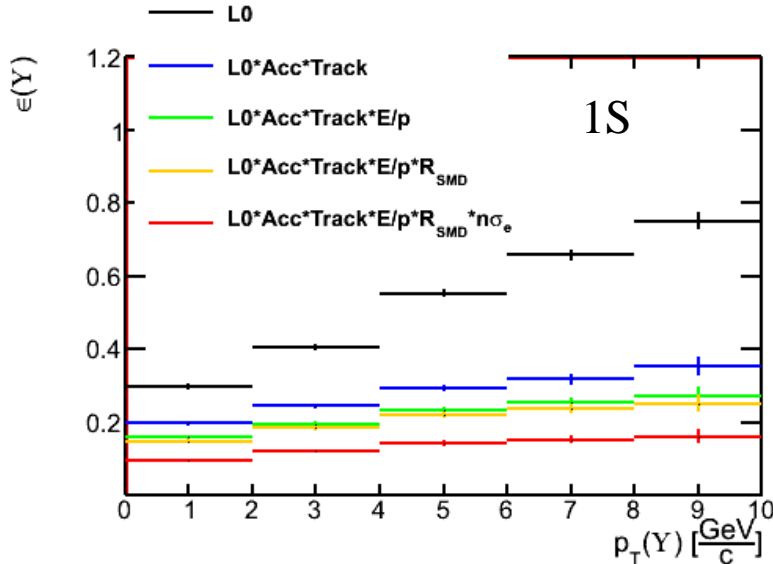
$0.55 < E_{\text{cluster}}/pc < 1.45$

Compared E_{clu}/p distribution from MC simulation and data



Data
 MC simulation $\Upsilon(1S)$
 MC simulation $\Upsilon(2S)$
 MC simulation $\Upsilon(3S)$

Upsilon efficiencies from simulation



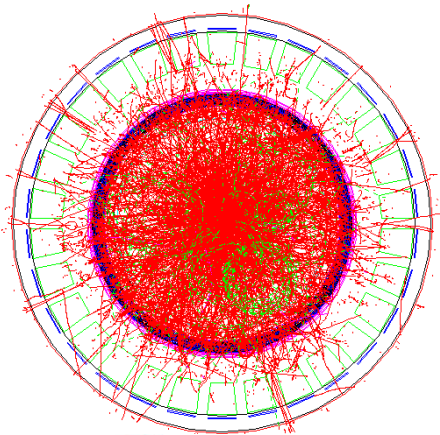
Upsilon reconstruction efficiency includes:

- L0 trigger efficiency
- Acceptance and tracking efficiency
- BEMC efficiencies
- dE/dx cut efficiency

Small differences between $\Upsilon(1S)$, $\Upsilon(2S)$ and $\Upsilon(3S)$ (due to kinematics)



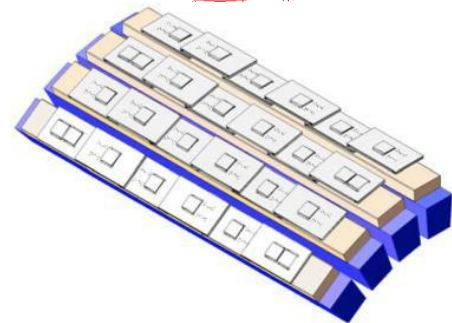
Muon Telescope Detector



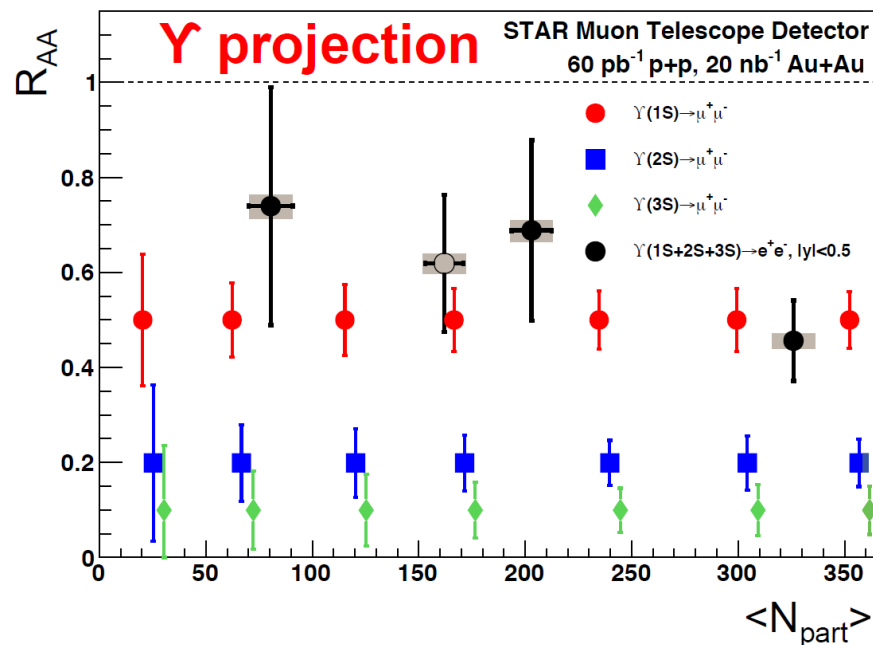
- Multi-gap Resistive Plate Chamber (MRPC) - gas detector outside STAR magnet

- Allows precision measurements of heavy quarkonia in dimuon channel (no γ conversions, less bremsstrahlung than e and less dalitz decays)

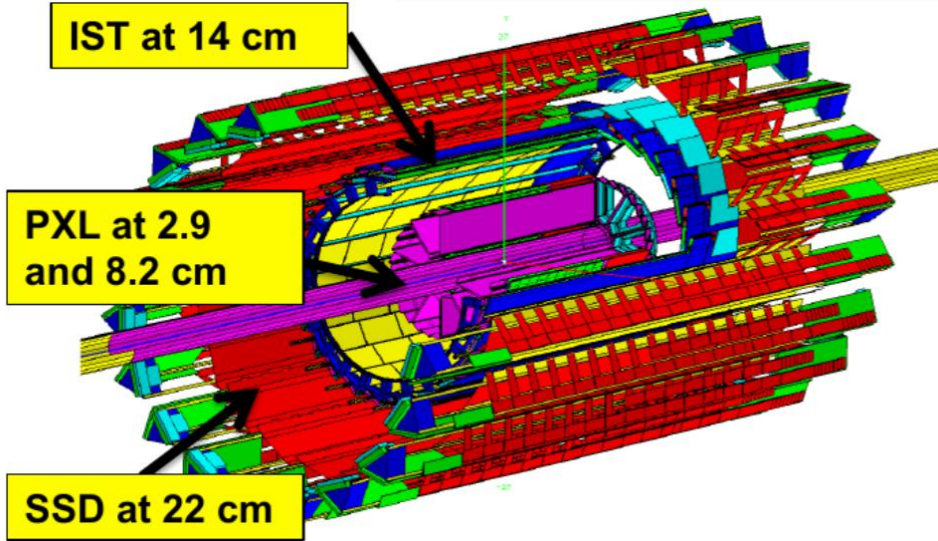
- Complete in 2014, sampled $\sim 13.8 \text{ nb}^{-1}$ in Au+Au data



Acceptance:
45% in ϕ
 $|\eta| < 0.5$



Heavy Flavor Tracker

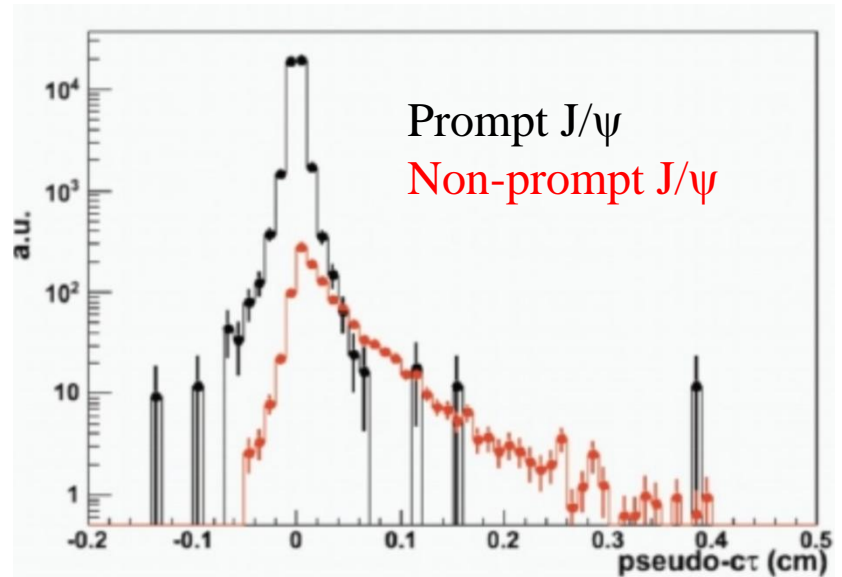


- State-of-the-art silicon tracker for heavy flavor studies
- Allows direct reconstruction of secondary vertices from D and B meson decays
- Fully installed in 2014, recorded ~1 billion Au+Au events

B measurement through non-prompt J/ψ :

$$B \rightarrow J/\psi + X \rightarrow e^+e^- + X$$

May provide direct $b\bar{b}$ cross section measurements



Summary

- Upsilon measurement in p+p 500 GeV could provide a better statistical precision baseline for Au+Au 200 GeV after extrapolation
- Data can be divided into 5 p_T bins from 0-10 GeV/c
- With current data ($L_{\text{int}} = 21.5 \text{ pb}^{-1}$), we can expect p_T spectrum for Upsilon 1S and combined states with statistical uncertainty $< 20\%$ for p_T up to 8 GeV/c
- Stay tuned for upcoming results!!

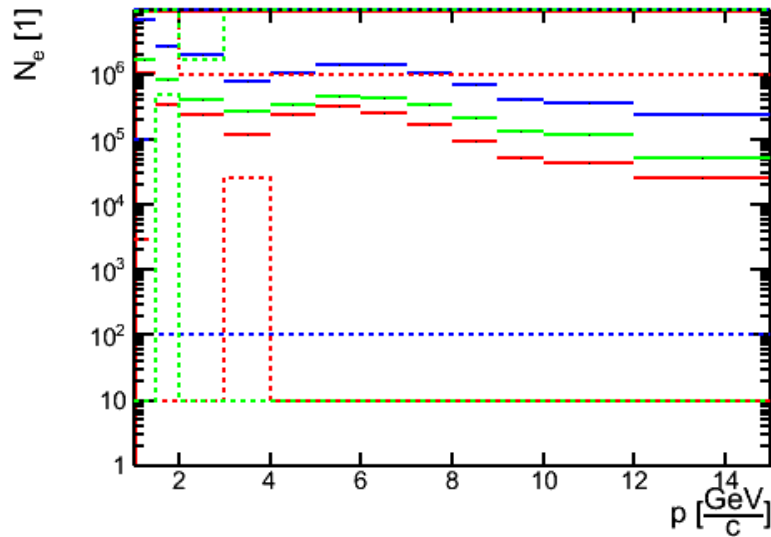


BACKUP

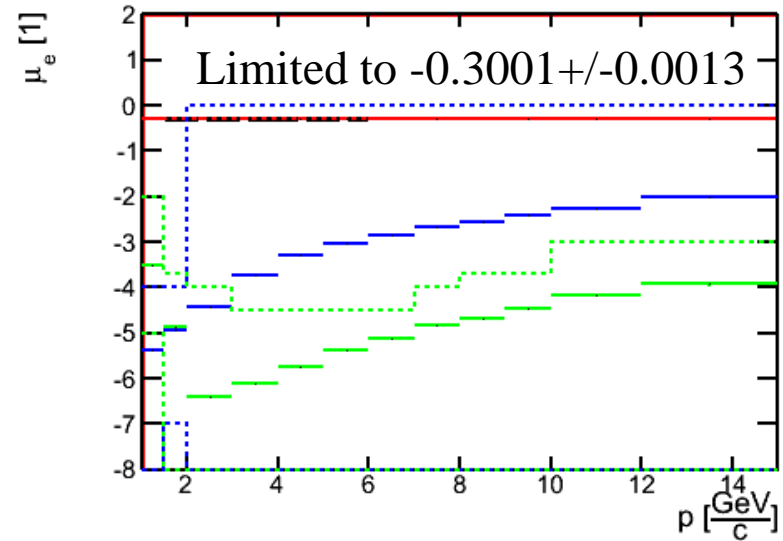


parameters

Electron yield

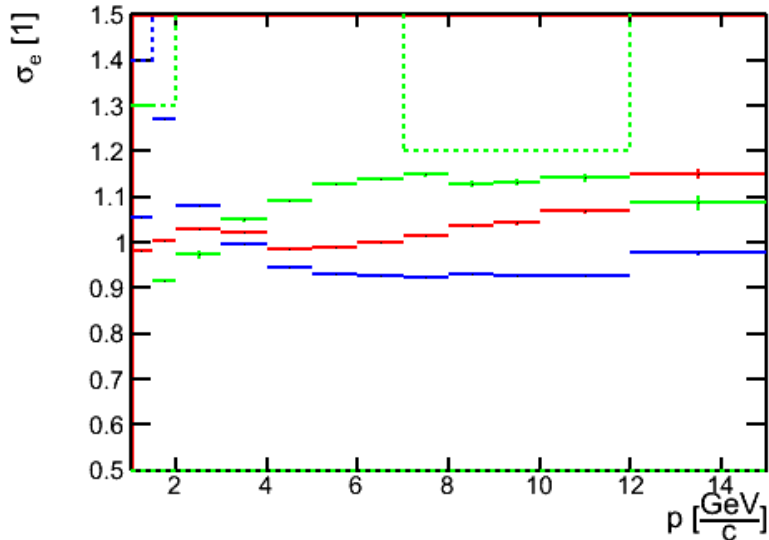


Electron mean



e
π
p
all

Electron sigma



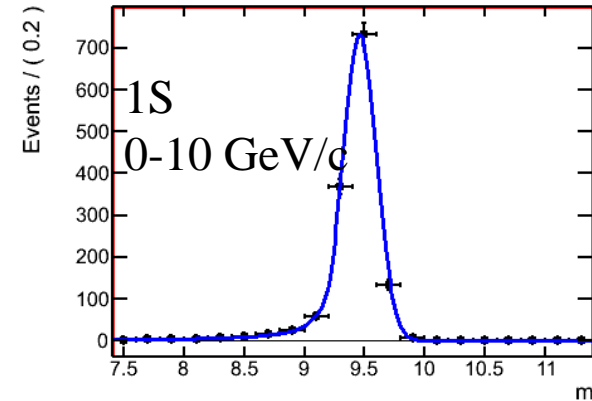
Smooth dependence => good

Set limit for electron mean based on
straight line fit in 1.5-6 GeV:
 -0.3001 ± 0.0013

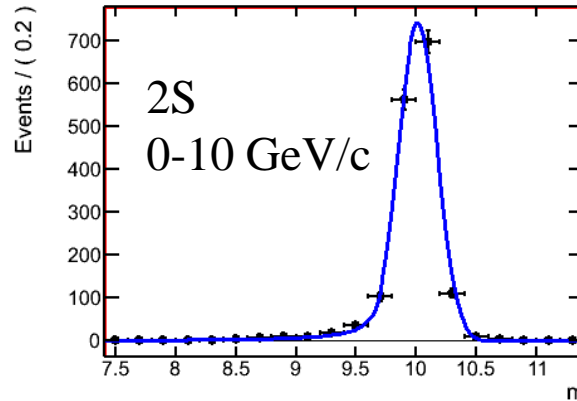
Very little constraints (dotted lines)

Upsilon lineshapes

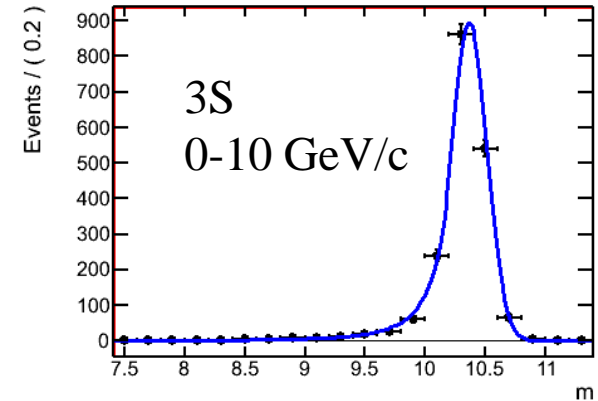
Lineshape_0.0<pT<10.0_GeV



Lineshape_0.0<pT<10.0_GeV



Lineshape_0.0<pT<10.0_GeV



Lineshapes from MC simulation include the reconstruction efficiency.

Fitted Crystal Ball functions to lineshapes

Made likelihood fits with RooFit in each p_T bin to take into account p_T dependence

Crystal Ball function:

$$f(x; \alpha, n, \bar{x}, \sigma) = N \begin{cases} \exp\left(-\frac{(x - \bar{x})^2}{2\sigma^2}\right), & \text{for } \frac{x - \bar{x}}{\sigma} > -\alpha \\ A\left(B - \frac{x - \bar{x}}{\sigma}\right)^{-n}, & \text{for } \frac{x - \bar{x}}{\sigma} \leq -\alpha \end{cases}$$

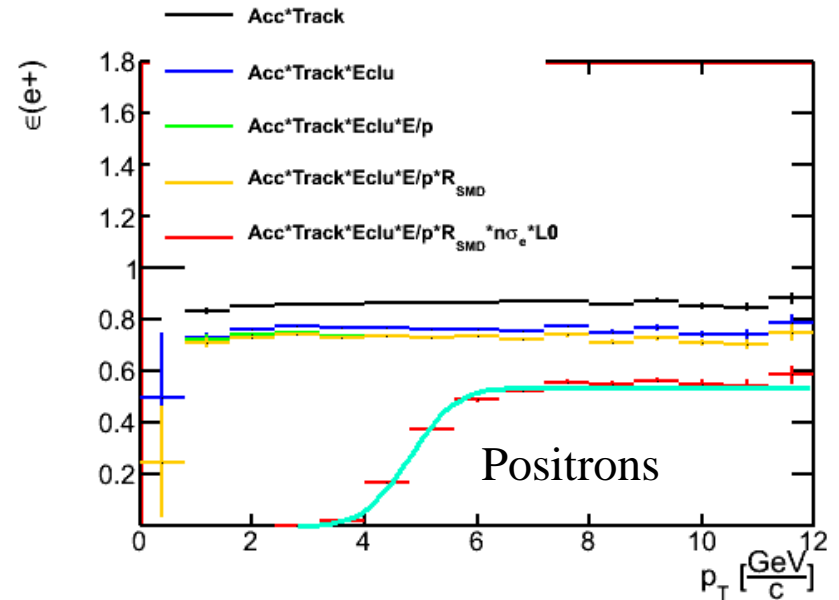
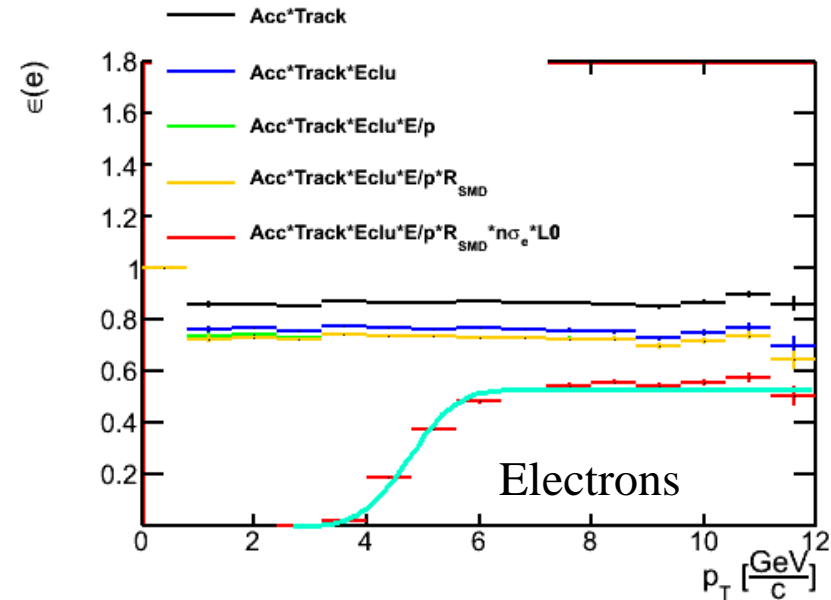
$$A = \left(\frac{n}{|\alpha|}\right)^n \cdot \exp\left(-\frac{|\alpha|^2}{2}\right) \quad C = \frac{n}{|\alpha|} \cdot \frac{1}{n-1} \cdot \exp\left(-\frac{|\alpha|^2}{2}\right)$$

$$B = \frac{n}{|\alpha|} - |\alpha| \quad D = \sqrt{\frac{\pi}{2}} \cdot \left(1 + \operatorname{erf}\left(\frac{|\alpha|}{\sqrt{2}}\right)\right)$$

$$N = \frac{1}{\sigma(C + D)}$$

DESY F31-86-02(1986), Appendix E

Electron efficiencies from simulation



Fit (teal):

$$A = 0.2662 \pm 0.0022$$

$$B = 4.752 \pm 0.018$$

$$C = 0.952 \pm 0.022$$

Fit function:

$$A \cdot \text{Erf} \left(\frac{p_T - B}{C} + 1 \right)$$

Fit (teal):

$$A = 0.2687 \pm 0.0022$$

$$B = 4.798 \pm 0.018$$

$$C = 0.944 \pm 0.022$$